Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/726,594	GYOUTOKU ET AL.	
Examiner	Art Unit	
Hai C. Pham	2861	

SEARCHED				
Class	Subclass	Date	Examiner	
347	129-130, 133, 236- 238, 253	3/22/2006	НР	
250	226	3/22/2006	HP	
310	89	3/22/2006	HP	
399	385	3/22/2006	HP	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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		DATE	EXMR
EAST Text Search		3/22/2006	HP
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